



### Measurements and evaluation of the cyclostationary characteristics for stochastic radiations from the Round Robin DUT

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# Outline

- Motivation The Intel® Galileo Board
- > Localization of the physical radiated sources of the DUT
- Frequency, time and spatial characterization of the physical radiated sources
- > Cyclostationary sources characterization in the near-field
- > Far-field analysis of the DUT's physical radiated sources
- Conclusion



# Motivation

**Electromagnetic radiation of the DUT** 

- ✓ stochastic: data transferring, thermal noise, jitter
- ✓ periodic deterministic: frequency synthesizer, power supply units, etc.
- Characteristics of stochastic signals
   ✓auto- and cross-correlation functions
   ✓cyclic cross-correlation cumulant functions
- Characteristics of periodic deterministic signals
   Fourier series expansion
   Power of spectral components



### **Device under test**

### ➤The Intel® Galileo Board







✓400MHz 32-bit Intel® Pentium processor

✓10/100 Ethernet connector

✓Full PCI Express\* mini-card slot

✓USB 2.0 Host connector



### **Device under test**





**Test modes** 

✓Memory test OFF

Memory test ON. Memory intensive process
 where random integer numbers are generated
 and will be saved in a random element in a large
 array allocated in the memory



## Near-field measurement setup





- ✓Langer near-field 10 mm probe
- $\checkmark Two polarization of the probe: H_X and H_Y$
- ✓Scanning area 75 x 85 mm
- ✓5 mm scanning step
- ✓4 mm distance between PCB and probe
- ✓13 GHz Oscilloscope LeCroy SDA 813Zi-A
- ✓2.5 GSa/s sampling frequency
- ✓5 MSa data length



### Near-field measurement setup





## Power hot spots of the DUT



### > H<sub>x</sub> polarization



✓ Power level 27 mV<sup>2</sup>

> H<sub>v</sub> polarization



# Memory hot spot



✓Measured signals are nonperiodic
✓Memory test signals are random
✓ Maximum of the PS at 118 MHz

### > Measured signals



### > Power spectrum



# Memory test on



### ✓Bit duration is 5.2 ns

✓The shape of pulses is identical

✓Memory test process is cyclostationary





# Memory test off



✓Pulse duration is 5.2 ns
✓Sequence of single pulses
✓Period of signal is 7.7 mks





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# Signal of the clock frequency synthesizer



✓Period of signal 40 ns✓Frequency bandwidth up to 1.25 GHz

### > Measured signals







# Spatial distribution of the clock signal



✓ Power level 3.5 mV<sup>2</sup>



# Signal of the switched mode power supply



✓Period of signal ~ 4 mks

✓Frequency bandwidth up to 40 MHz

#### > Measured signals







# Cyclostationary sources characterization

The periodic sample mean function of the cyclostationary process

$$m_{\mathcal{X}}(\alpha,t) = \lim_{N \to \infty} \frac{1}{2N+1} \sum_{n=-N}^{N} x\left(t+nT\right) = \sum_{k=-\infty}^{\infty} e^{\frac{j2\pi kt}{T}} \lim_{\Delta \to \infty} \frac{1}{\Delta} \int_{-\frac{\Delta}{2}}^{\frac{\Delta}{2}} x\left(\zeta\right) e^{-j2\pi\alpha k\zeta} d\zeta$$

Nonlinear inertialess shifted transformation of the signal

$$z(t,\tau) = x(t-\tau/2)x(t+\tau/2)$$

### **Cyclic autocorrelation function**

$$R_{\chi}(\alpha,\tau) = \lim_{\Delta \to \infty} \frac{1}{\Delta} \int_{-\frac{\Delta}{2}}^{\frac{\Delta}{2}} z(t,\tau) e^{-j2\pi\alpha t} dt$$



### Cyclostationary sources characterization

**Non-periodic second order cyclic cumulant function** 

$$C_{\mathcal{X}}(\alpha,\tau) = \lim_{\Delta \to \infty} \frac{1}{\Delta} \int_{-\frac{\Delta}{2}}^{\frac{\Delta}{2}} \left[ x \left( t - \frac{\tau}{2} \right) - m_{\mathcal{X}} \left( \alpha, \left( t - \frac{\tau}{2} \right) \right) \right] \left[ x \left( t + \frac{\tau}{2} \right) - m_{\mathcal{X}} \left( \alpha, \left( t + \frac{\tau}{2} \right) \right) \right] e^{-j2\pi\alpha t} dt$$

**Cyclic cross-correlation cumulant function (cyclic CCCF)** 

$$C_{\mathcal{YX}_{mn}}\left(\alpha_{1},\tau\right) = \lim_{\Delta \to \infty} \frac{1}{\Delta} \int_{-\frac{\Delta}{2}}^{\frac{\Delta}{2}} \left[ y\left(t - \frac{\tau}{2}\right) - m_{y}\left(\alpha_{1},\left(t - \frac{\tau}{2}\right)\right) \right] \left[ x_{mn}\left(t + \frac{\tau}{2}\right) - m_{x_{mn}}\left(\alpha_{1},\left(t + \frac{\tau}{2}\right)\right) \right] e^{-j2\pi\alpha_{1}t} dt$$



## **Cyclic auto-correlation cumulant functions**

#### Memory test on

> Memory test off





✓ Power level 165 mV<sup>2</sup>

✓ Power level 25 mV<sup>2</sup>



# **Cyclic auto-correlation cumulant functions**

#### Power spectrum

> Cyclic ACCF



Maximum of cyclic ACCF corresponds to the cyclic frequency 190.5 MHz
 Cyclic frequency is suppressed in the power spectrum



# **Cyclic auto-correlation cumulant functions**

 $\succ$  Cyclic frequency  $\alpha = 0$ 

> Cyclic frequency  $\alpha = 190.5$  MHz



✓Correlation interval corresponds to the pulse duration 5.2 ns✓Both slices are nearly identical



# Spatial distribution of the cyclic CCCF





# Spatial distribution of the cyclic CCCF







### Far-field measurement setup





 $\checkmark$  H<sub>x</sub> polarization



 $\checkmark$  H<sub>y</sub> polarization



### **Far-field measurements**





## **Far-field measurements**

> Power of the clock signal, test on







 $\checkmark Distance 1 m \\ \checkmark \Theta = 90^{\circ}$ 

## **Far-field measurements**

> Power of the clock signal, test off





 $\checkmark Distance 1 m \\ \checkmark \Theta = 0^{\circ}$ 

✓ Distance 1 m ✓  $\Theta = 90^{\circ}$ 

# Conclusion

- Localization of the physical radiated sources of the DUT was performed
- Frequency, time and spatial characterization of the physical radiated sources have been obtained
- Characterization of the random data signals reveals hidden cyclic frequencies of the sequence
- Far-field analysis of the DUT's physical radiated sources was accomplished in anechoic chamber



# **Publications**

- **EMC Europe 2018 Symposium, August 27-30, Amsterdam, Netherlands**
- > 2018 Baltic URSI Symposium, May 14-17, Poznań, Poland
- > 2nd URSI AT-RASC, 28 May 1 June, Gran Canarias
- European Microwave Week 2018, September 23-28, Madrid, Spain

